SN54LS446, SN54LS449, SN74LS446, SN74LS449 QUADRUPLE BUS TRANSCEIVERS WITH INDIVIDUAL DIRECTION CONTROLS

SDLS178

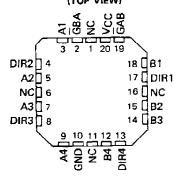
D2613, OCTOBER 1980-REVISED MARCH 1988

3-State Outputs Drive Bus Lines Directly

- P-N-P Inputs Reduce DC Loading on Bus Line
- Hysteresis at Bus Inputs Improves Noise Margins
- Flow-Thru Data Pinout (B Bus Opposite Δ Bus)
- Choice of True ('LS449) and Inverting ('LS446)

SN54LS446, SN54LS449 . . . J PACKAGE SN74LS446, SN74LS449 . . . D OR N PACKAGE (TOP VIEW) GBA 1 16 VCC A1 🗍 2 15 GAB 14 🗌 B1 DIR2∏3 13 DIR1 **A**2∏4 12 B2 **A3**∏5 DIR3∏6 11 🗆 B3 10 DIR4 A4 7 9 B4 GND[]8

SN54LS446, SN54LS449 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

description

These quadruple bus transceivers are designed for data transmission from individual lines of the A bus to individual lines of the B bus or the reverse, depending on the logic levels at the direction-control pins DIR1 through DIR4. These direction controls (one for each channel) allow maximum flexibility in timing. The enable inputs $\overline{G}BA$ and $\overline{G}AB$ can be used to disable the A or B outputs respectively, or to disable both buses for effective isolation.

The SN54LS446 and SN54LS449 are characterized for operation over the full military temperature range of -55°C to 125°C . The SN74LS446 and SN74LS449 are characterized for operation from 0°C to 70°C .

FUNCTION TABLE

ENABLE		DIRECTION	OPERATION	OPERATION		
G BA	ĞАВ	DIR	'L\$446	'LS449		
Н	н	х	Isolation	Isolation		
Х	L	н	A data to B Bus	A data to B Bus		
L	×	L	B date to A Bus	B data to A Bus		
х	Н	Н	Isolation	Isolation		
Н	×	L	Isolation	Isolation		

H = high level, L = low level, X = irrelevant

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)		 			7 V
Input voltage		 		<i></i>	7 V
Off-state output voltage					
Operating free-air temperature range:	SN54LS'	 	. <i>.</i>	, , 	−55°C to 125°C
	SN74LS'	 			0°C to 70°C
Storage temperature range		 	. <i>.</i>	<i></i>	-65°C to 150°C

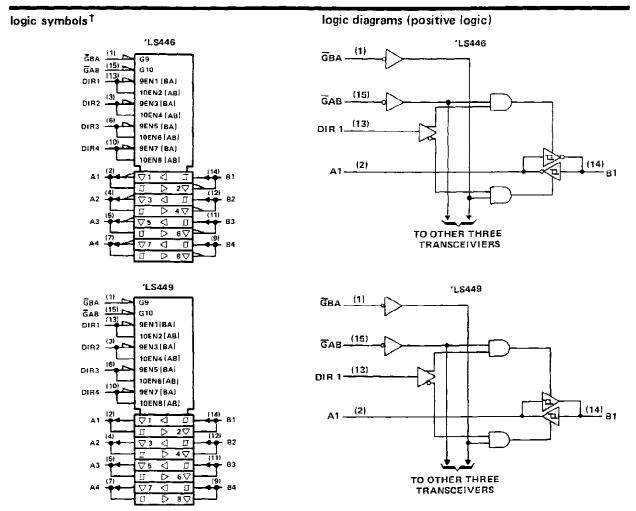
NOTE 1: Voltage values are with respect to the network ground terminal.

PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



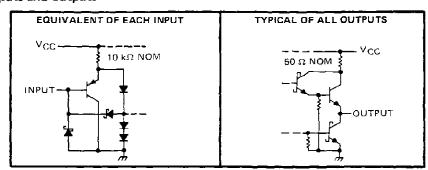
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SN54LS446, SN54LS449, SN74LS446, SN74LS449 QUADRUPLE BUS TRANSCEIVERS WITH INDIVIDUAL DIRECTION CONTROLS



 $^{^\}dagger$ These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for D, J, and N packages.

schematics of inputs and outputs



SN54LS446, SN54LS449, SN74LS446, SN74LS449 QUADRUPLE BUS TRANSCEIVERS WITH INDIVIDUAL DIRECTION CONTROLS

recommended operating conditions

PARAMETER	į	146 149	12	UNIT			
	MIN	NOM	MAX	MIN	NOM	MAX]
Supply voltage, V _{CC} (see Note 1)	4.5	5	5.5	4,75	5	5.25	V
High-level output current, IOH		_	-12			15	mA
Low-level putput current, IQL			12			24	πА
Operating free-air temperature, TA	-55		125	0		70	°c

NOTE 1: Voltage values are with respect to network ground terminal.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER			TEST CONDITIONS†		1	154LS44 154LS44		S S	UNIT		
				MIN	TYP‡	MAX	MIN	түр‡	MAX		
ViH	High-level input voltage		1		2			2			V
VIL	Low-level input voltage						0.6			0.7	٧
Vik	Input clamp voltage		VCC = MIN,	l =18 mA			-1.5			-1.5	V
	Hysteresis ($V_{T+} - V_{T-}$),	A or B input	V _{CC} = MIN		0.1	0.4		0.2	0.4		<u> </u>
∨он	High-level output voltage		V _{CC} = MIN, V _{IH} = 2 V,	I _{OH} =3 mA	2.4	3.4		2.4	3.4	·	
YOH			VIL = VIL max	I _{OH} = MAX	2			2			,
Vol	Low-level output voltage		V _{CC} = MIN,	IOL = 12 mA		0.25	0.4		0.25	0.4	V
VOL			VIL = VIL max	I _{OL} = 24 mA		0.	0.35	0.5			
lozh	Off-state output current,		V _{CC} = MAX, V _O = 2,7 V	\bar{G} at 2 V,			20			20	μА
		igh-level voltage applied			<u> </u>			<u> </u>			
lozu	Off-state output current, low-level voltage applied		V _{CC} = MAX, V _O = 0.4 V	$\overline{\mathbf{G}}$ at 2 V,	•		-0.4			- 0.4	mA
- -	Input current at	A or B	 	V ₁ = 5.5 V	 		0.1			0,1	<u> </u>
11	maximum input voltage	GAB or GBA	Vcc = MAX,	V ₁ = 7 V	†		0.1			0.1	mA
1H	High-level input current	L	V _{CC} = MAX,				20			20	μА
IIL	Low-level input current		V _{CC} - MAX,				-0.4			-0.4	mA
los	Short-circuit output curre	nt§	V _{CC} = MAX		-40		-225	-40	•	-225	mА
	Total supply current	l		Outputs high		35	56		35	56	
		'LS446		Outputs low	1	39	63	\Box	39	63]
,,,,		·	VCC = MAX,	Outputs at Hi-Z		42	68		42	68	mA
1cc			Outputs open	Outputs high	1	42	68		42	68] '''
		'LS449	ì	Outputs low		47	75		47	75	
			ļ	Outputs at Hi-Z		50	80		50	80	

 $^{^{\}dagger}$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

 $^{^{\}ddagger}$ All typical values are at V_{CC} = 5 V, T_A = 25 °C.

Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

SN54LS446, SN54LS449, SN74LS446, SN74LS449 QUADRUPLE BUS TRANSCEIVERS WITH INDIVIDUAL DIRECTION CONTROLS

switching characteristics at V_{CC} = 5 V, T_A = 25°C

PARAMETER		FROM TO (INPUT) (OUTPUT)		TEST CONDITIONS	'LS446			'LS449			UNIT	
				FEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	L CIVIT	
	Propagation delay time,	А	В			8	13		10	15		
†PLH	low-to-high-level output	В	А	0 - 45 - 5		8	13		10	15	ns	
	Propagation delay time,	Α	В	C _L = 45 pF,		7	12		11	17		
₹PHL	high-to-low-level output	В	Α	E 207.0		7	12		11	17	ns	
•	Output enable time to low level	ĞΒΑ	Α	$R_{\perp} = 667 \Omega$,		24	40		21	35		
†PZL		ĞΑΒ	В	See Mary 3		24	40		21	35	∩5	
Ţ.	O	ĞΒΑ	Α	See Note 2		15	25		18	30		
'PZH	Output enable time to high level	GAB	В			15	25		18	30	ns	
	Output disable time from low level	ĞBA A	Α	0 -5-5		14	25		14	25		
IPLZ		ĞAB	В	C _L = 5 pF,		14	25		14	25	ns	
	Output disable time from high level	ĞΒΑ	Α	-	R _L =667Ω,		10	15		10	15	
TPHZ		ĞАВ	В	See Note 2		10	15		10	15	П5	

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

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